

# MIDLAND METROLOGY LTD

## iMetal-630B/BD

### Upright Metallographic Microscope



# Feature and Application

iMetal-630 is a professional-grade upright metallographic microscope designed for material metallographic analysis. It supports bright field, bright-dark field, polarizing observation and differential interference contrast (DIC). Equipped with an intelligent light intensity management LED system featuring a 50,000-hour long-life light source with stable color rendering, it also has a 30° inclined trinocular observation tube and 10X wide-field eyepieces. Optional multi-magnification plan achromatic objectives are available, adapting to various observation modes such as bright field, polarizing and DIC. The microscope adopts a right-handle detachable stage with a stroke of 75\*50mm for easy operation, and is compatible with a standard C-mount for flexible expansion of cameras and software. It meets the needs of tissue observation and failure analysis of metals, semiconductors and other materials in scientific research and industrial testing, serving as a reliable tool in the field of material analysis.

## Product Feature

- It adopts an infinite optical system, matched with plan semi-apochromatic objectives and large-field high-eyepoint eyepieces, restoring the true details of metallographic structures to meet high-precision testing requirements. The
- optimal light intensity is automatically matched when switching objective magnifications, eliminating the need for repeated manual adjustment, reducing operational steps, avoiding human errors and greatly improving testing fluency.
- 10W 4500K wide-spectrum LED with CRI≥95, preset centering, stepless brightness adjustment and a variable aperture.
- A rich variety of optional accessories are available, including bright-dark field illumination, polarizing observation and DIC observation.
- The coarse and fine coaxial focusing system (1μm fine adjustment scale value) and 75×50mm large-travel stage are combined with a five-hole encoded nosepiece, realizing precise positioning, smooth operation and stable precision during long-term use.



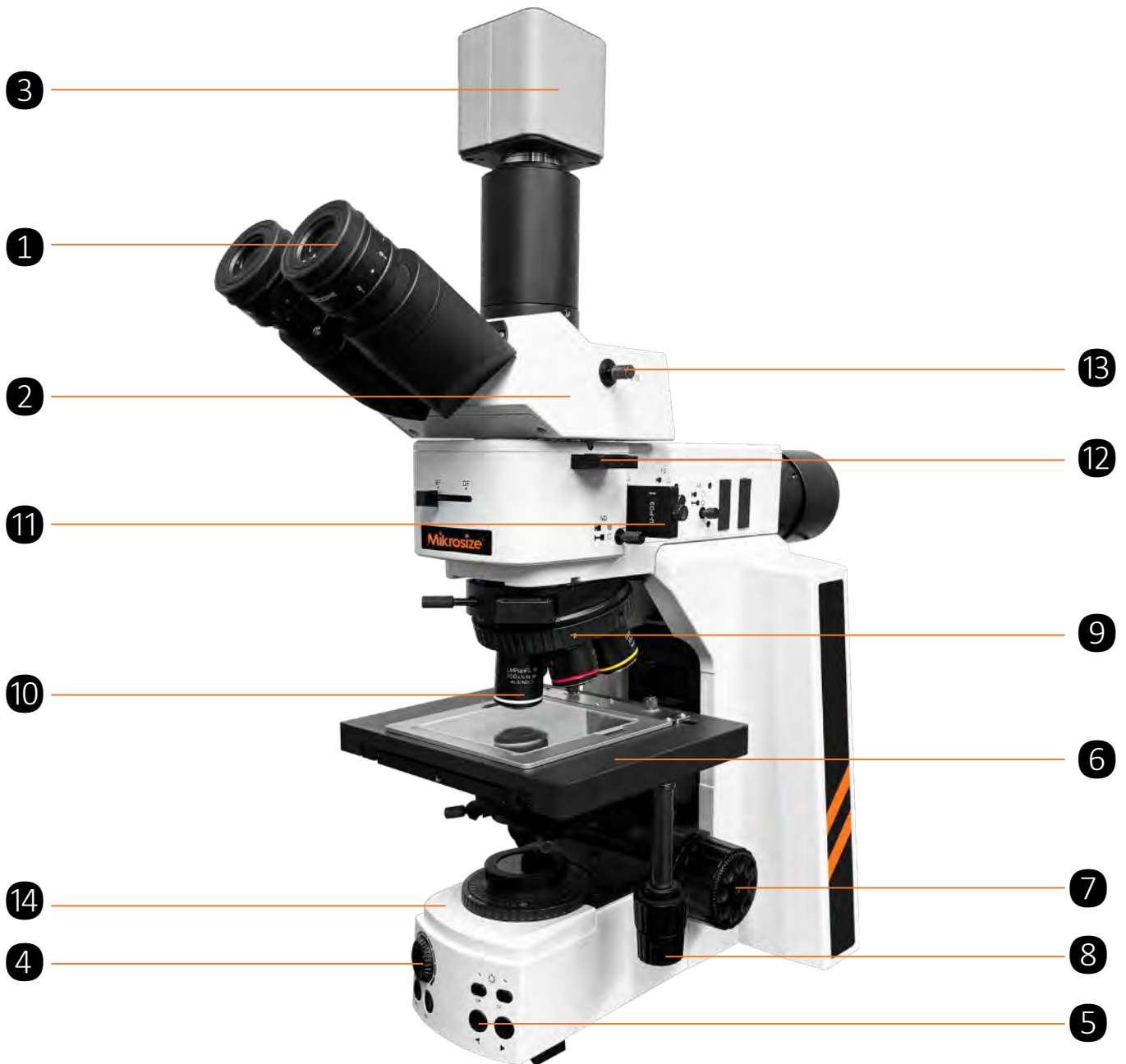
# Feature and Application



## Product Application

- Used for grading the grain size and inclusions of steel, non-ferrous metals and other materials, and evaluating the effect of heat treatment processes and material properties. Detecting defects such as cracks, blowholes and porosity in castings and weldments, tracing the causes of failure to ensure the quality and reliability of products.
- Accurately observing microstructural changes after processes such as quenching and annealing.
- Optimizing process parameters to ensure the process stability of mass production. Clearly presenting the microstructures of weld fusion zones and heat-affected zones, detecting defects such as incomplete penetration and slag inclusions to meet the acceptance criteria of welding processes.
- Observing the porosity and sintered structure of powder metallurgy parts, as well as the thickness and bonding interface of coatings and platings to control coating quality.
- Suitable for teaching experiments in materials science for metallographic structure observation and material performance analysis.

# Product Details



**1.Eyepiece**

**2.Trinocular Observation Tube**

**3.Camera**

**4.Light Source Control Knobs and Buttons**

**5.Objective Switching Button**

**6.Workbench**

**7.Coarse And Fine Coaxial Adjustment Knob**

**8.Workbench Control Handle**

**9.Nosepiece**

**10.Objective Lens**

**11.Polarizer**

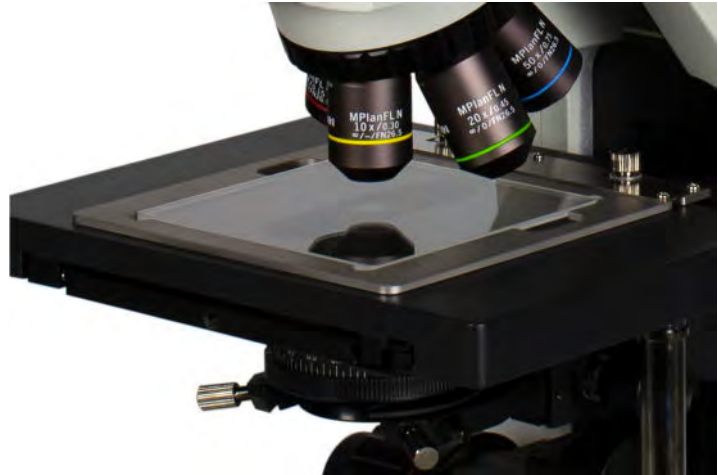
**12.Analyzer**

**13.Bright-Dark Field Switching Lever**

**14.Dic Slot**

# Product Details

## Product Structure



- Ultra-large travel range of 75\*50mm
- Ergonomically designed stage knobs and focusing knobs
- Customizable stage accessories for special samples



- Objective Lens Options
- Plan objectives: 5X、10X、20X、50X、100X
- Semi-apochromatic objectives: 2.5X、5X、10X、20X、50X、100X
- Apochromatic objectives: 5X、10X、20X、50X、100X
- The iMetal-630 is standard equipped with a five-hole encoded nosepiece, which allows for the integration of the microscope's hardware settings with image analysis software, where illumination intensity and objective position are both recorded in the software.

# Product Details

## Product Structure

- Coaxial coarse and fine adjustment knobs with adjustable tightness and a 1  $\mu\text{m}$  fine focusing scale value for smooth and accurate adjustment.

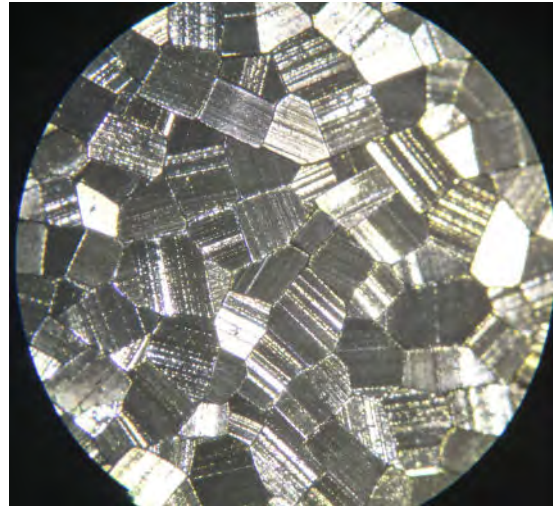
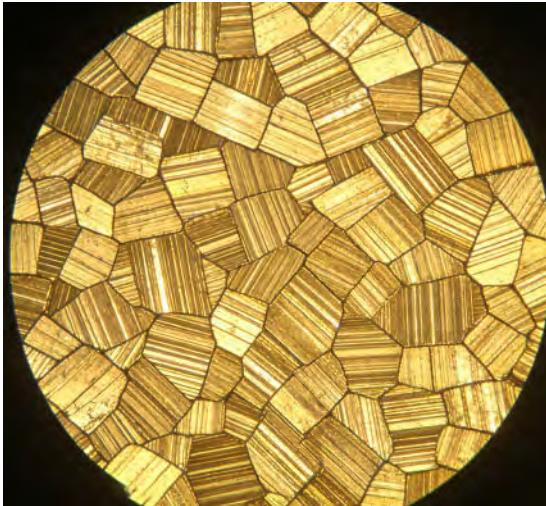


- 4500K wide-spectrum LED with  $\text{CRI} \geq 95$ , preset centering, stepless brightness adjustment and a variable aperture; built-in bright field and dark field modules, including a fixed polarizer and a 360° rotatable analyzer.
- True color imaging can be fully achieved at both high and low brightness levels.
- Generates almost no heat, with illumination intensity equivalent to a 100W halogen lamp.
- Stepless adjustment of illumination intensity; the desired illumination intensity can be set for each objective lens, and the illumination intensity is automatically adjusted when switching objectives.

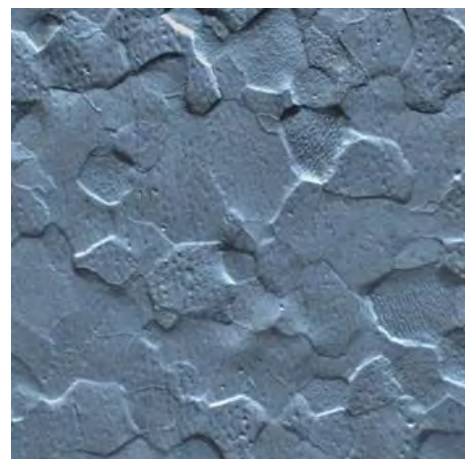
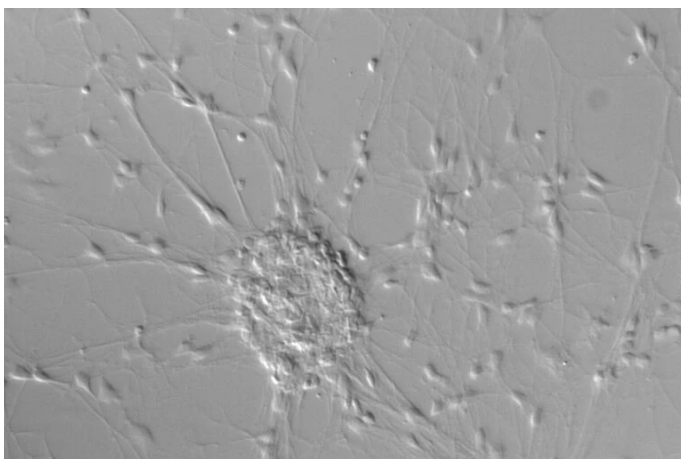
# Product Details

## Optical Path Switching

- The iMetal-630 supports optional bright-dark field, polarizing observation and differential interference contrast (DIC), which can be selected by customers according to their needs.



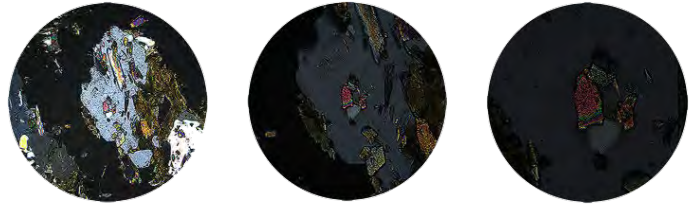
- Simultaneous bright-dark field comparison of samples: the bright field displays the overall morphology, while the dark field highlights defects, particles and transparent edges with stronger contrast for easier flaw detection.



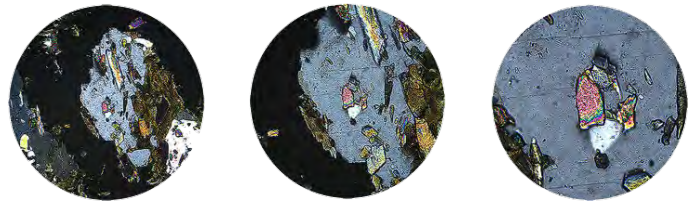
- DIC observation delivers a 3D embossed effect with a strong sense of depth, clear edges and no halation, ensuring more accurate details. It enables sample observation without staining, which is sample-friendly.

# Product Details

## Intelligent Light Intensity Management System



- For traditional microscopes, the image becomes darker when increasing the objective magnification.



- The intelligent light intensity management system automatically adjusts the light intensity to the optimal level when changing the objective magnification.

## LED Light Source



- Halogen lamps: color rendering changes at different light intensity levels.

- LED light source: constant and consistent color rendering at different light intensity levels, with more vivid colors than halogen lamps.



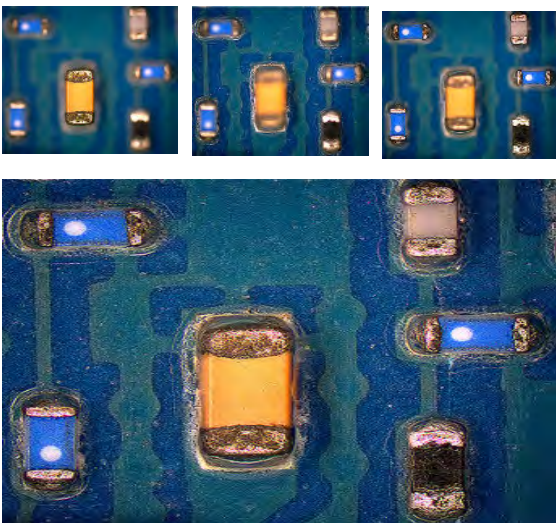
# Software (Standard Delivery)

## Software Function: Image Stitching



- The real-time image stitching function adopts image recognition technology; a panoramic image can be obtained simply by moving the stage knobs, providing a wider field of view for users.

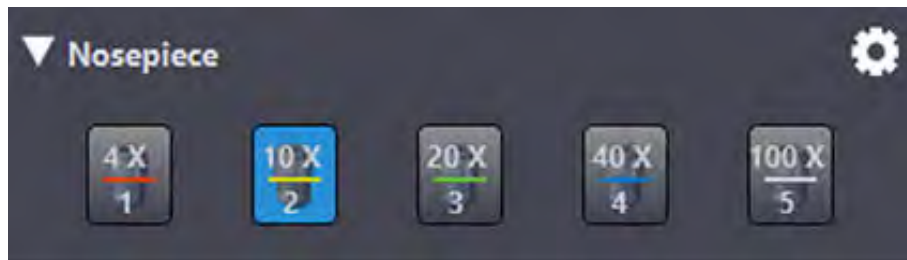
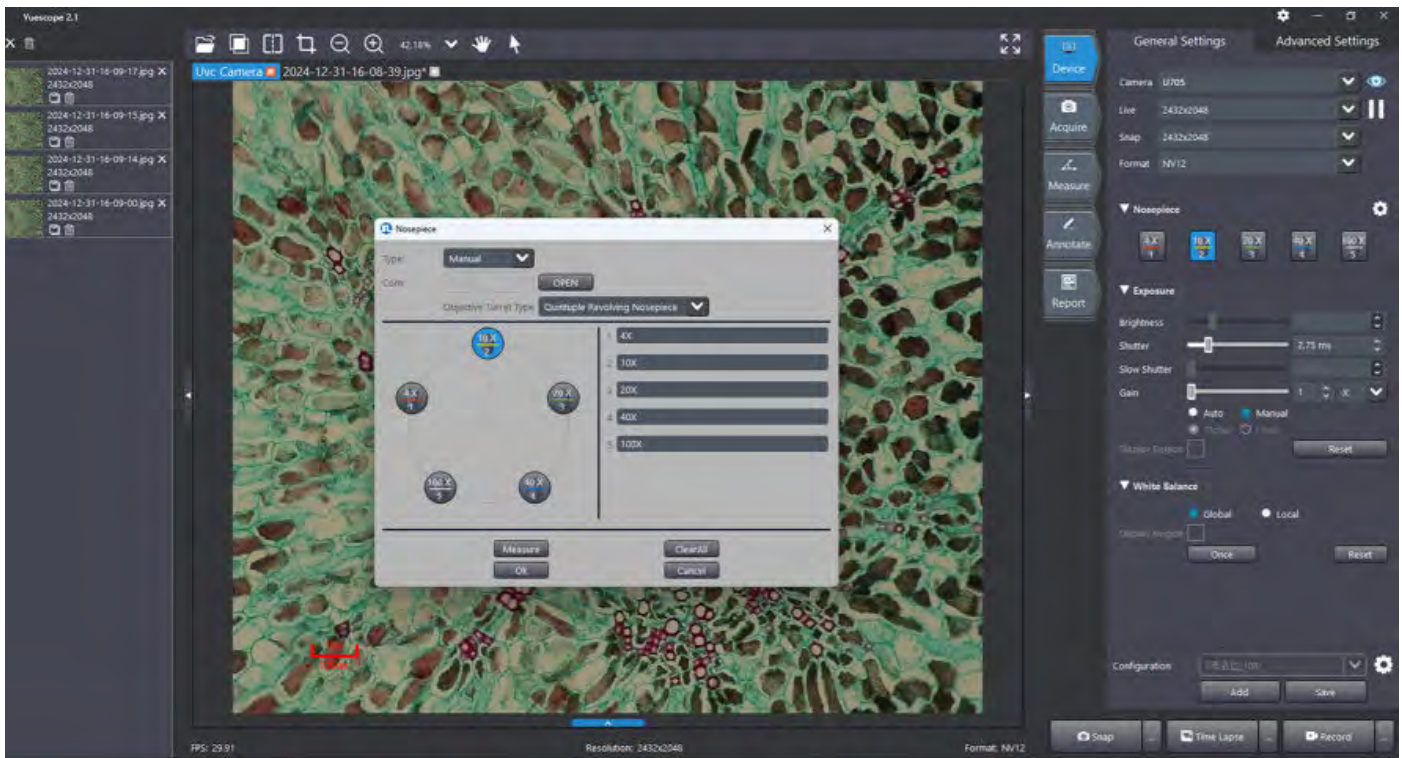
## Software Function: Depth of Field Fusion



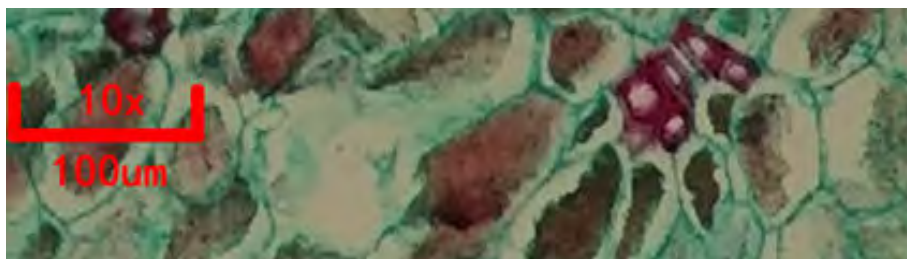
- The real-time depth of field fusion function can capture sample images with a height exceeding the objective depth of field and stack them to create an ultra-depth of field image.

# Software Operation Interface

## Software Functions



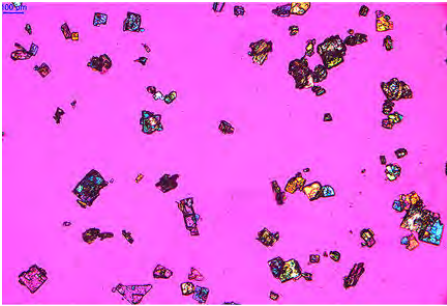
- Active objective lens recognition by software



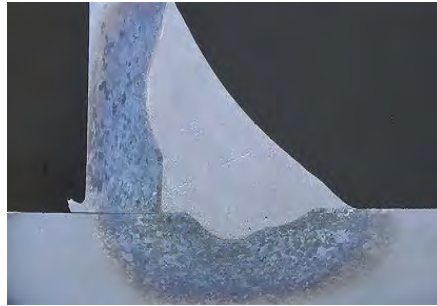
- Automatic scale bar switching by software when changing objectives

# Software Operation Interface

## Measurement Imaging



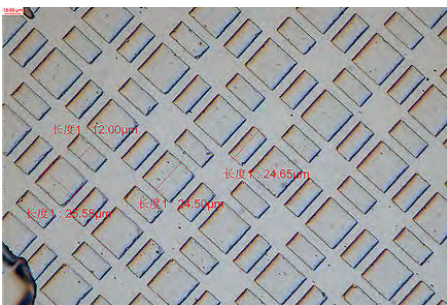
The drug powder under polarized light



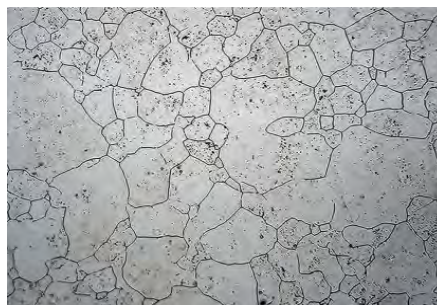
Measurement of aluminum alloy melting depth



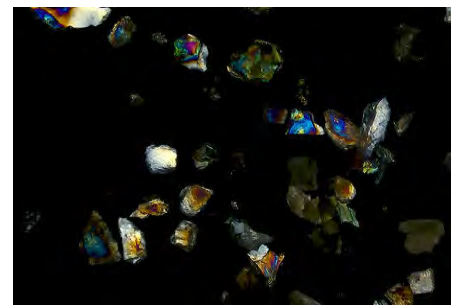
Capacitor tin plating height detection



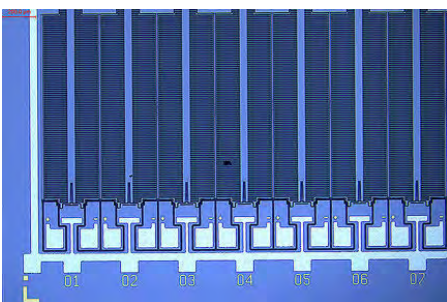
OLED photoresist material



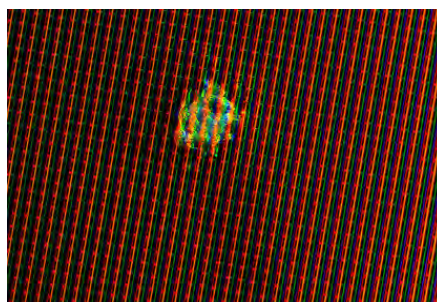
Metallographic structure analysis



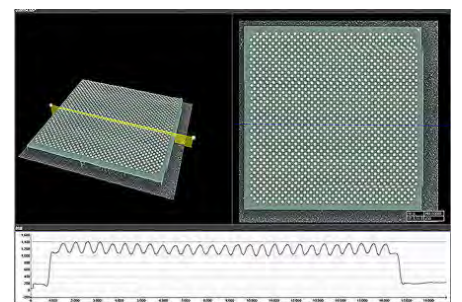
Phase analysis of rocks



Semiconductor testing



Display screen defect detection



The 3D shape of the tin ball

# Technical Specification

<b>Model</b>	iMetal-600B	iMetal-600BD
<b>Optical Path</b>	Bright Field	Bright and Dark Field
<b>Optical system</b>	Infinite optical system, intelligent light intensity management LED system	Infinite optical system, intelligent light intensity management LED system
<b>Observation tube</b>	Hinged trinocular observation tube (compatible with imaging system), 30° inclined, interpupillary distance 50-75mm, adjustable eyepoint, beam splitter ratio 100:0, 50:50	Hinged trinocular observation tube (compatible with imaging system), 30° inclined, interpupillary distance 50-75mm, adjustable eyepoint, beam splitter ratio 100:0, 50:50
<b>Eyepiece</b>	Ultra-wide field eyepiece 10X (field number $\Phi$ 23mm), high eyepoint, diopter adjustable	Ultra-wide field eyepiece 10X (field number $\Phi$ 23mm), high eyepoint, diopter adjustable
<b>Objective Lens</b>	MPLFL5X,NA=0.15, WD=14.8mm	LMPLFL5X,NA=0.15, WD=16.5mm
	MPLFL10X,NA=0.3, WD=8.5mm	LMPLFL10X,NA=0.3, WD=11.7mm
	MPLFL20X,NA=0.45,WD=3.5mm	LMPLFL20X,NA=0.45, WD=13mm
	MPLFL50X,NA=0.75,WD=3mm	LMPLFL50X,NA=0.8, WD=3.5mm
<b>Polarization Observation</b>	Transmission/ reflection polarizer 360° rotatable analyzer	Transmission/ reflection polarizer 360° rotatable analyzer

# Technical Specification

<b>Objective Nosepiece</b>	Five-hole encoded nose-piece (RMS)	Detachable 5-hole encoded nosepiece (M26) with DIC slot
<b>DIC Observation</b>	High-resolution DIC, adjustable focal length (optional) High-resolution DIC, fixed focal length (optional)	High-resolution DIC, adjustable focal length (optional) High-resolution DIC, fixed focal length (optional)
<b>Reflective Lighting System</b>	LED illumination, color temperature 4400K-4600K, CRI≥95	LED illumination, color temperature 4400K-4600K, CRI≥95
<b>Reflective Observation</b>	Bright field Kohler illumination system, 50,000-hour LED light source	Bright field Kohler illumination system, 50,000-hour LED light source
<b>Focusing System</b>	Coarse and fine coaxial, adjustable tightness, 1μm fine adjustment scale value	Coarse and fine coaxial, adjustable tightness, 1μm fine adjustment scale value
<b>Stage Size</b>	Double-layer mechanical moving stage, 135*125mm, stroke 75*50mm	Double-layer mechanical moving stage, 135*125mm, stroke 75*50mm
<b>Glass Stage Size</b>	101*101mm	101*101mm
<b>Intelligent Management</b>	The control circuit automatically adjusts the light intensity to the optimal level when changing the objective magnification	The control circuit automatically adjusts the light intensity to the optimal level when changing the objective magnification
<b>Camera Interface</b>	Standard C-mount 0.5X, parfocal adjustable, suitable for CCD within 2/3 inch	Standard C-mount 0.5X, parfocal adjustable, suitable for CCD within 2/3 inch

# Standard Delivery

Name	Qty	Photo	
<b>Mainframe</b>	1pc		
<b>Eyepiece 10X/23mm</b>	2pcs		
<b>Objective (Bright Field Semi-Apochromatic)</b>	MPL5X,NA=0.15,WD=14.8mm	1pc	
	MPL10X,NA=0.3,WD=8.5mm	1pc	
	MPL20X,NA=0.45,WD=3.5mm	1pc	
	MPL50X,NA=0.75,WD=3mm	1pc	
<b>Objective (Bright-Dark Field Semi-Apochromatic)</b>	LMPLFL5X,NA=0.15,WD=16.5mm	1pc	/
	LMPLFL10X,NA=0.3,WD=11.7mm	1pc	
	LMPLFL20X,NA=0.45,WD=13mm	1pc	
	LMPLFL50X,NA=0.8,WD=3.5mm	1pc	
<b>Nosepiece</b>	1pc		


# Standard Delivery

Name	Qty	Photo
<b>Stage</b>	1pc	
<b>Polarizer</b>	1pc	
<b>Analyzer</b>	1pc	
<b>20MP Industrial Camera</b>	1pc	
<b>0.5X C-mount Camera Interface</b>	1pc	

# Standard Delivery

Name	Qty	Photo
<b>Instruction Manual</b>	1pc	
<b>High-precision Micrometer (0.01mm scale value)</b>	1pc	
<b>Dust Cover</b>	1pc	
<b>Power Cord</b>	1pc	
<b>Camera Cable</b>	1pc	

# Optional Delivery

<b>Observation Tube</b>	Trinocular observation tube, 30° inclined; Beam splitter ratio: eyepiece=100:0, 0:100
<b>Eyepiece</b>	10X/25mm, diopter adjustable
<b>Objective Lens</b>	MPLFL2.5X NA0.08 WD9.8
	MPLFL100X NA0.9 WD1
	LMPLFL100XBD NA0.9 WD1.1
	LMPLAP050XBD NA0.6 WD8.8
<b>Camera Adaptor</b>	LMPLAP0100XBD NA0.85 WD3.3
	Standard C-mount 0.65X, parfocal adjustable, suitable for CCD within 1 inch
	Standard C-mount 1X, parfocal adjustable, suitable for CCD within 4/3 inch
<b>Differential Interference Contrast (DIC)</b>	High-resolution DIC, adjustable focal length High-resolution DIC, fixed focal length
<b>Reflected Observation</b>	Bright field/fluorescence switchable critical illumination system with 50,000-hour LED light source
<b>Stage</b>	100*100 stroke stage
<b>Nosepiece</b>	Detachable 6-hole encoded nosepiece (RMS) with DIC slot, 5 holes of which are center adjustable
<b>Metallographic Microscopic Analysis Software</b>	

# Metallographic Microscope Camera (Optional Delivery)

L3CMOS05100KPA Metallographic Microscope Camera



# Product Introduction

L3CMOS05100KPA adopts the Aptina AR0521 color CMOS sensor and delivers professional imaging performance with 5.1 megapixels. The large pixel size of  $2.2\mu\text{m}$  ensures excellent light collection capability and signal-to-noise ratio performance, and the 73dB dynamic range guarantees rich image gradations. With a full-resolution frame rate of 15.5fps, it strikes an ideal balance between real-time observation and recording, making it an optimal choice for microscopic teaching and scientific research.

## Product Features

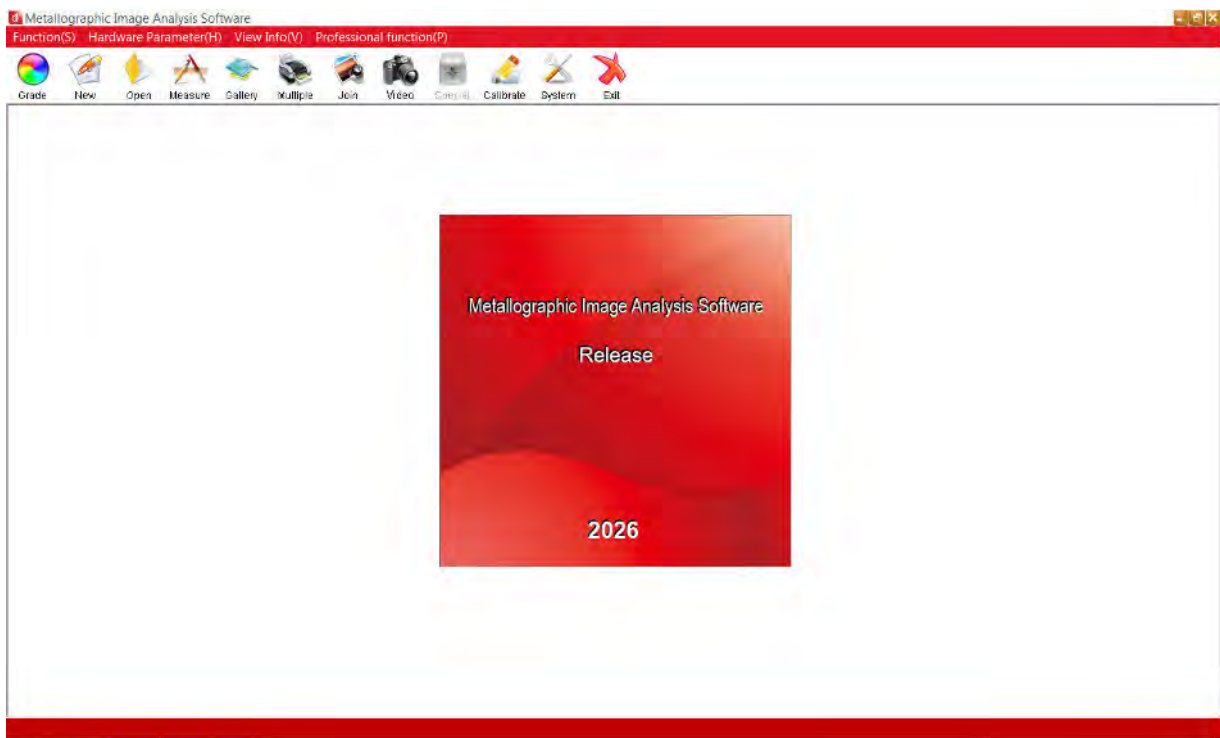
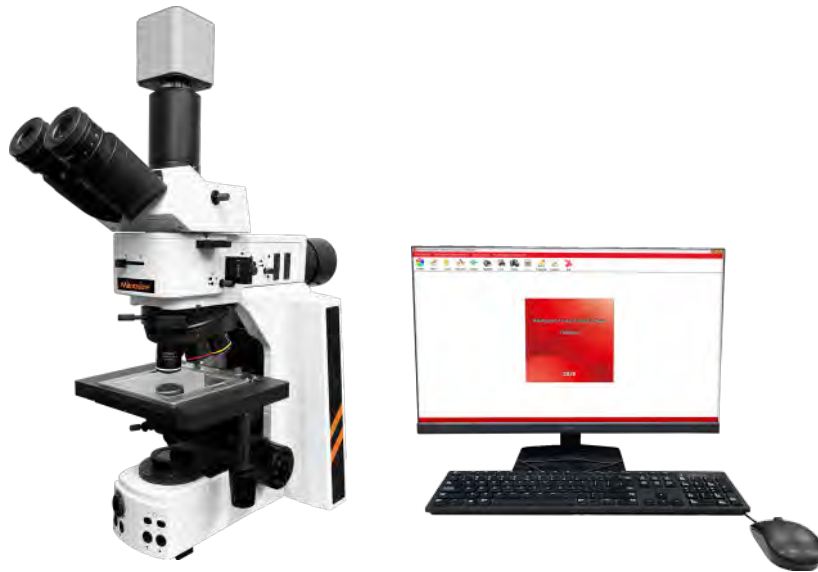
- Adopts an infinite optical system, matched with plan semi-apochromatic objective lenses and wide-field high-eye-point eyepieces to restore the true details of metallographic structures and meet the requirements of high-precision detection.
- The full range of objective lenses has a long working distance; the max. 50X magnification still maintains an 8.5mm working distance, enabling the observation of large-size and special-shaped samples without frequent sample preparation, thus improving detection efficiency.
- Automatically matches the optimal light intensity when switching objective lens magnifications, eliminating the need for repeated manual adjustment, reducing operational steps, avoiding human errors, and greatly improving detection fluency.
- 4000K-4300K warm white LED light source with a color rendering index (CRI)  $\geq 95$  accurately restores the true color of samples, avoids misjudgment caused by color deviation, and is suitable for metallographic rating and image analysis.
- $45^\circ$  inclined hinged trinocular tube with a beam splitter ratio of 100:0/0:100 supports simultaneous connection of human eye observation and imaging systems, meeting the needs of photographing, video recording and digital archiving.
- Coaxial coarse and fine focusing system ( $1\mu\text{m}$  fine focusing graduation) +  $50\times 50\text{mm}$  large-stroke stage, combined with a 5-hole encoded nosepiece, realizes precise positioning, smooth operation and stable precision during long-term use.



# Technical Specification

<b>Sensor</b>	AR0521(C)
<b>Effective Pixels / Resolution</b>	5.1 Megapixel (2592×1944)
<b>Frame Rate (Full Resolution)</b>	15.5fps@2592x1944; 49.5fps@1296x972; 97.5fps@648x486
<b>Shutter Type</b>	Rolling Shutter
<b>Color Type</b>	Color
<b>Pixel Size</b>	2.2μm × 2.2μm
<b>Target Surface Size</b>	5.70mm × 4.28mm
<b>Diagonal</b>	0.4" (7.13mm)
<b>Dynamic Range</b>	73dB
<b>Bit Depth</b>	8bit
<b>Sensitivity</b>	18.8ke-/lux
<b>Data Interface</b>	USB3.0
<b>Lens Mount</b>	C-mount
<b>Overall Dimension</b>	80*80*45mm
<b>Weight</b>	0.8Kg
<b>Power Supply</b>	USB Powered
<b>Operating Temperature / Humidity</b>	-10°C ~ 50°C / 30%~80%RH
<b>Storage Temperature / Humidity</b>	-20°C ~ 60°C / 10%~60%RH

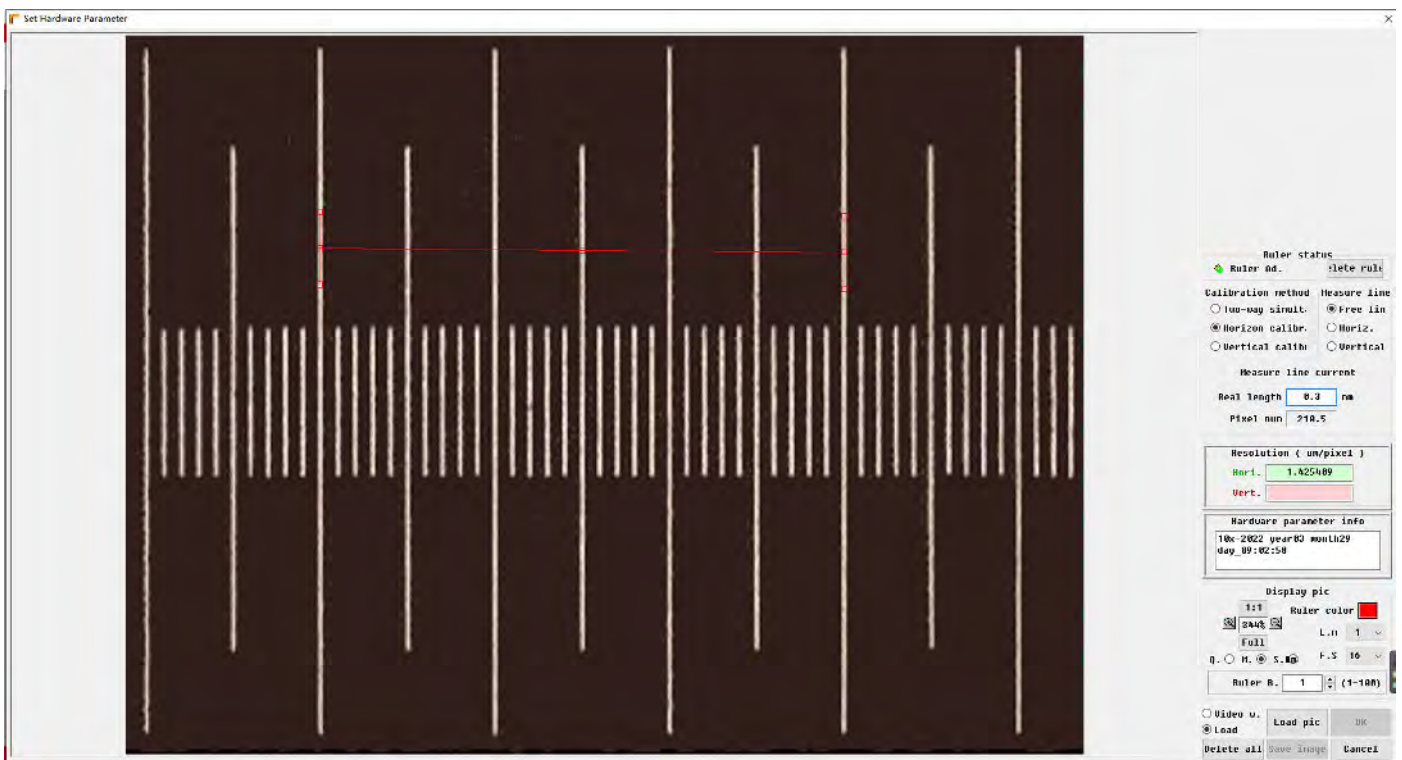
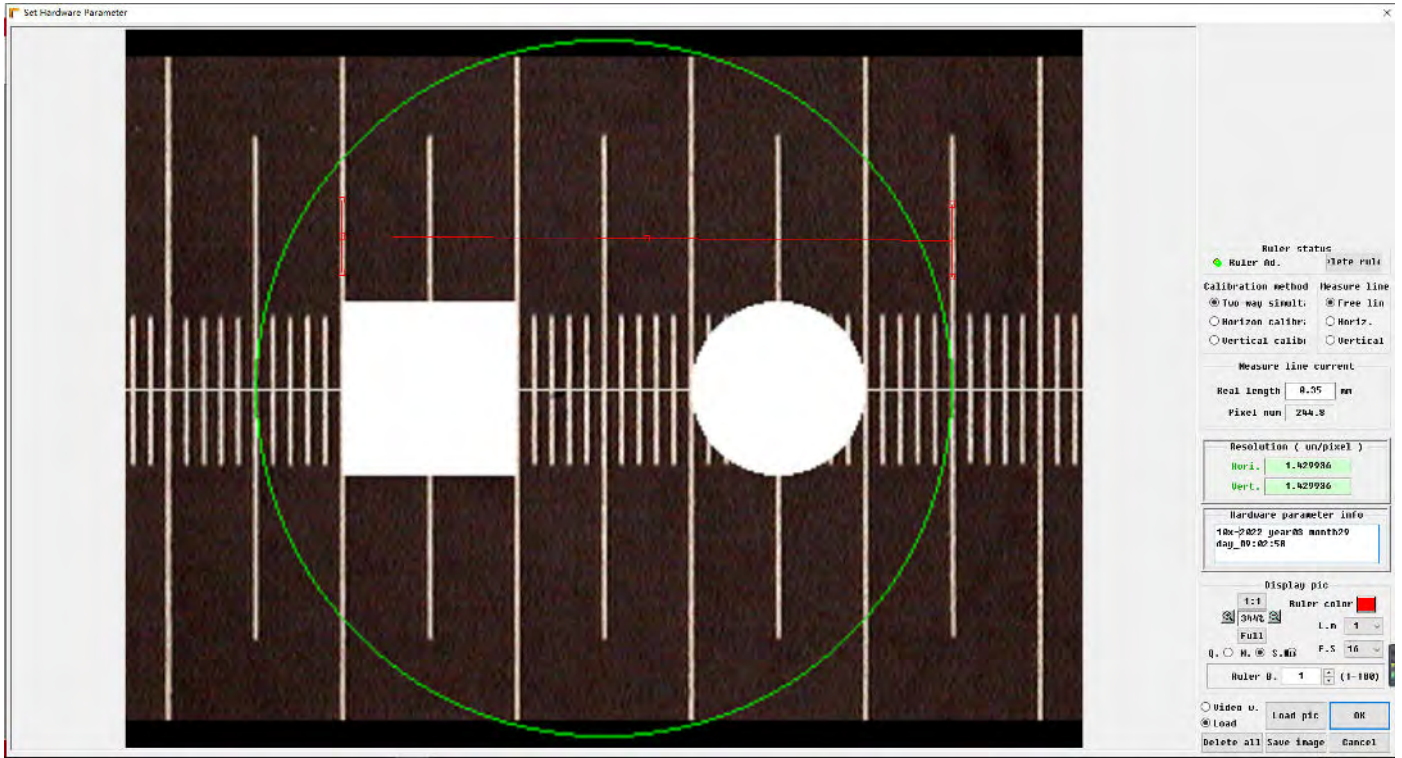
# iMetal-MA Metallographic Analysis Software



- The software supports hardware calibration and metallographic grade evaluation, covering international testing modules for grain size, inclusions etc. It has basic functions such as image preprocessing, accurate geometric measurement, multi-format report export and fixed-magnification printing, as well as image stitching, video acquisition, confocal imaging and 3D optical imaging etc. It supports atlas comparison and data statistics, It meets the standardized requirements of the entire metallographic testing process and is compatible with the Windows 7, 10 and 11 operating systems.

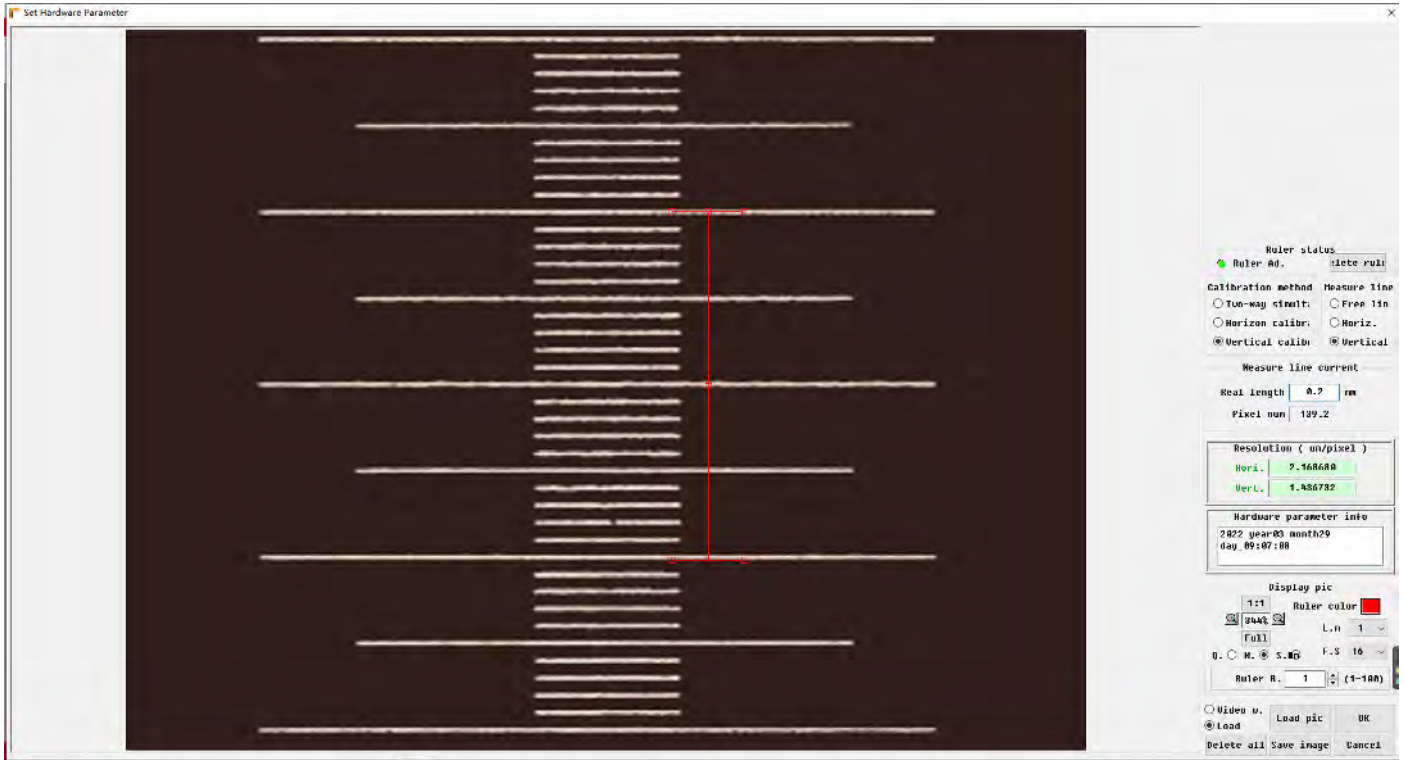
# Operation Interface

## Image Calibration



# Operation Interface

## Image Calibration



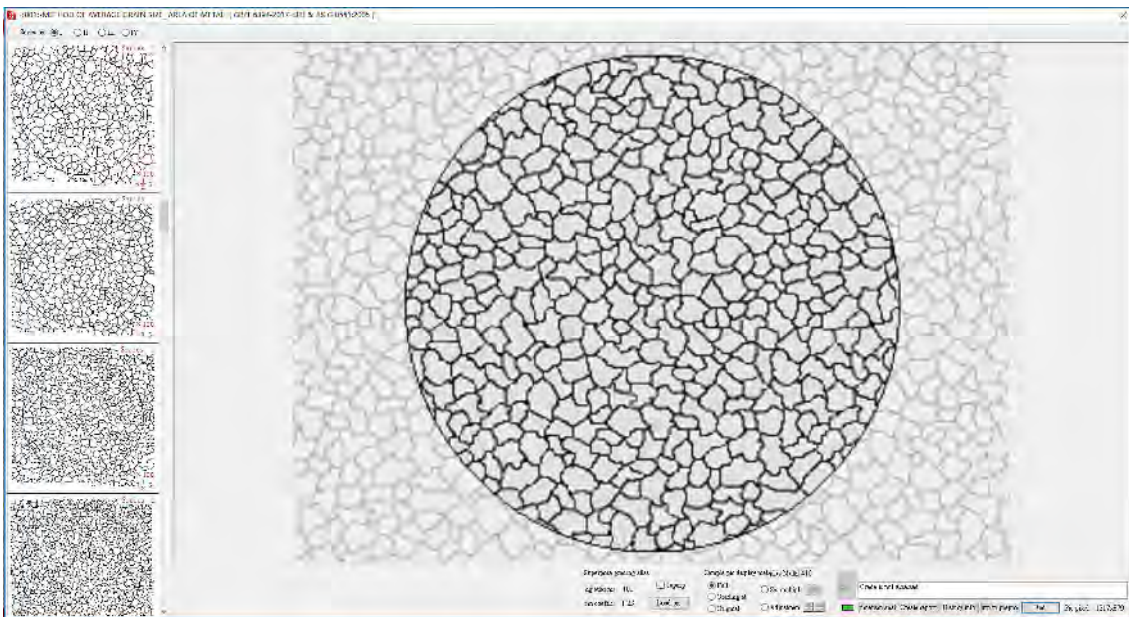
- The software supports three calibration methods (bidirectional simultaneous, horizontal and vertical) to adapt to different testing scenarios.
- The resolution can be automatically calculated only by loading the micrometer image, dragging the scale and entering the actual length, featuring simple and easy operation.
- The calibration results can be verified through geometric measurement with the error controlled within a minimal range, laying an accurate hardware foundation for subsequent measurement and grading. Meanwhile, it supports the export and import of resolution parameters to realize rapid reuse across multiple devices and scenarios.

# Operation Interface

## Metallographic Grade Evaluation Function

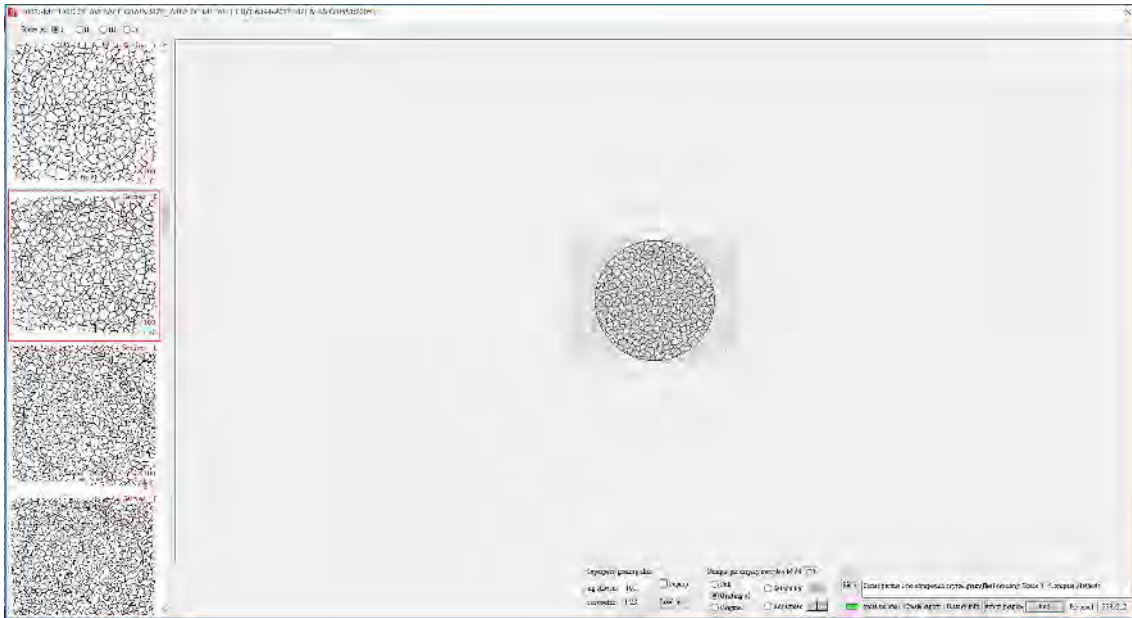
Select analysis item

0001	METHOD OF AVERAGE GRAIN SIZE AREA OF METAL	DE/T 8894-2017(8.2) & JIS C
0002	METAL AVERAGE GRAIN SIZE DUTTING POINT METHOD	DE/T 8894-2017(8.2)
0003	METAL AVERAGE GRAIN SIZE COMPARISON METHOD	DE/T 8894-2017(8.1)
0004	Details of Average Grain Size Testing For Better Results and Aliases	OSTN 8894-2017(8.07)
0005	Standard For Dual Grain Size Characterization Test Method Area Fraction Evaluation Comparison Chart	OSTN 8181-2002
0006	Standard For Dual Grain Size Characterization Test Method 01 Micrographs of Dual Grain Size Types	OSTN 8181-2002
0007	Standard For Dual Grain Size Characterization Test Method 02 Micrographs of Dual Grain Size Types	OSTN 8181-2002
0008	Standard For Dual Grain Size Characterization Test Method 03 Application of Statistical Program For Determining Grain Size Distribution	OSTN 8181-2002
0009	Steel Microscopic determination of average grain size (area method)	ISO 648:2012
0010	Steel Microscopic determination of average grain size (perimeter method)	ISO 648:2012
0011	Standard Grading Diagram Microscopic Method For The Determination of Non-metallic Inclusions in Steel	DE/T 14561-2005 / JIS 4047
0012	METHOD FOR EVALUATION OF INCLUSIONS CONTENT IN STEEL METHOD 0 (EAST OJEM METHOD)	OSTN 826-2015
0013	Method For Evaluating Inclusion Content in Steel Method 0 (Low Inclusion Content Method)	OSTN 826-2015
0014	Method For Evaluating Inclusion Content in Steel Method 1	OSTN 826-2015
0015	Metallographic examination Method. Microscopic examination of non-metallic inclusions in high quality steel by metallographic analysis	DIN 54626:1985
0016	Metallographic examination of previous metal surface defects	DE 3494-88
0017	DETERMINATION OF FERRITE GRAIN SIZE OF LOW CARBON STEEL COLD ROLLED SHEET GRAIN ELONGATION	DE 7210-2009(4.2)
0018	DETERMINATION OF FERRITE GRAIN SIZE OF LOW CARBON STEEL COLD ROLLED SHEET GRAIN ELONGATION	DE 7210-2009(4.2)
0019	Determination of Phase Area Content of Stainless Steel	DE 6491-80
0020	Metallographic Examination of Draw Back Iron Graphite Distribution Shape	DE 7210-2009(4.1)
0021	Metallographic Examination of Draw Back Iron Graphite Length (Manual Analysis)	DE 7210-2009(4.2)
0022	Metallographic Inspection of Draw Back Iron Graphite Length (Automatic Analysis)	DE 7210-2009(4.2)
0023	Metallographic Examination of Draw Back Iron Number of Pearlitic	DE 7210-2009(4.3)
0024	Metallographic Examination of Draw Back Iron Number of Pearlitic	DE 7210-2009(4.3)
0025	Metallographic Examination of Draw Back Iron Number of Phosphorus Eutectic	DE 7210-2009(4.5)
0026	Metallographic Examination of Draw Back Iron Determination of the Number of Eutectic Groups of Draw Back Iron	DE/T 7210-2009(4.6)
0027	Metallographic examination of draw back iron phosphorus eutectic type etc	DE 7210-2009(appendix B)
0028	Quantitative metallographic determination	DE 7210-2009(appendix B)
0029	Free cementite	DE/T 13220-2015 (1)
0030	Ferrite in Low Carbon Deformed Steel	DE/T 13220-2015 (2)
0031	Zonal tissue	DE/T 13220-2015 (3)
0032	Microstructure	DE/T 13220-2015 (4)
0033	Microstructure assessment of steel calculation of Troostite Content	DE 1979
0034	Metallographic Measurement Metal Length Rating of Emburized Beads For Automobile	DD/T 266-1999
0035	Metallographic Retained Austenite Rating of Emburized Beads For Automobile	DD/T 266-1999
0036	Metallographic Retained Austenite Rating of Emburized Beads For Automobile	DD/T 266-1999
0037	Measurement of Metallographic Austenite Content in Emburized Beads of Automobile	DD/T 266-1999
0038	Metallographic Examination of Emburized Beads For Automobile Rating of Layers of Martensite Residue (Measurement Method)	DD/T 266-1999
0039	Metallographic examination of modular cast iron classification and evaluation of spheroidization	DE/T 2441-2009(4.1)
0040	Metallographic Examination of Ductile Iron Size and Evaluation of Graphite	DE/T 2441-2009(4.2)
0041	Metallographic Examination of Ductile Iron Number of Pearlitic (Suitable For Lead Pearlitic)	DE/T 2441-2009(4.3)
0042	Metallographic Examination of Ductile Iron Number of Pearlitic (Suitable For Pearlitic Alloy)	DE/T 2441-2009(4.3)
0043	Metallographic Examination of Ductile Iron Quantitative Grading of Dispersed Ferrite	DE/T 2441-2009(4.4)
0044	Metallographic Examination of Ductile Iron Number of Phosphorus Eutectic	DE/T 2441-2009(4.5)
0045	Metallographic Examination of Ductile Iron Number of Pearlitic	DE/T 2441-2009(4.6)
0046	Metallographic Examination of Ductile Iron Number of Graphite Spheres	DE/T 2441-2009(4.7)
0047	Metallographic Examination of Ductile Iron Quantitative Grading of Ferrite and Pearlitic (Percentage of Graphite and Densitite)	DE/T 2441-2009
0048	Technical Conditions For Heat Treatment of High Carbon Chromium Stainless Steel Rolling Bearing Parts Annular Type Microstructure of Level 1 Diagram	JB/T 1460-2002
0049	Technical Conditions For Heat Treatment of High Carbon Chromium Stainless Steel Rolling Bearing Parts Secondary Stage Diagram Quenching and Tempering Microstructure	JB/T 1460-2002
0050	Technical Conditions For Heat Treatment of High Carbon Chromium Stainless Steel Rolling Bearing Parts Fracture Organization of Level 2 Diagram	JB/T 1460-2002
0051	Metallographic examination of cast aluminum alloy. Non-modification of cast Al-Si alloy	JB/T7946.1-2017
0052	Structure modification of cast hypoeutectic Al-Si alloy and eutectic Al-Si alloy	JB/T7946.1-2017
0053	Antimony modification of cast hypoeutectic Al-Si alloy	JB/T7946.1-2017
0054	Phosphorus modification of cast eutectic Al-Si alloy	JB/T7946.1-2017
0055	Phosphorus modification of cast hypoeutectic Al-Si alloy	JB/T7946.1-2017
0056	Cast Al-Si alloy overburning	JB/T7946.2-2017
0057	Aluminum of cast aluminum alloy	JB/T7946.3-2017
0058	Metallographic examination of cast aluminum alloy. Grain Size of Cast Al-Si alloy	JB/T 7946.4-2017
0059	High Speed Tool Steel Large Section Forged Steel Eutectic Carbide	DE 5946-88
0060	Microstructure Inspection Method For Deformed Aluminum and Aluminum Alloy Products Part 1 Microstructure Inspection Method Identifying Filars (5)	DE/T 3240.1-2012
0061	Microstructure Inspection Method For Deformed Aluminum and Aluminum Alloy Products Part 1 Microstructure Inspection Method Identification of Deformed Aluminum Alloy Microstructure (6.1)	DE/T 3240.1-2012
0062	Microstructure Inspection Method For Deformed Aluminum and Aluminum Alloy Products Part 1 Microstructure Inspection Method High Temperature Oxidation (6.2)	DE/T 3240.1-2012
0063	Microstructure Inspection Method For Deformed Aluminum and Aluminum Alloy Products Part 1 Microstructure Inspection Method Blauding Layer (6.3)	DE/T 3240.1-2012
0064	Microstructure Inspection Method For Deformed Aluminum and Aluminum Alloy Products Part 1 Microstructure Inspection Method Copper Diffusion	DE/T 3240.1-2012
0065	Microstructure Inspection Method For Deformed Aluminum and Aluminum Alloy Products Part 1 Microstructure Inspection Method Determination of Grain Size and Dislocation Method (7.2)	DE/T 3240.1-2012
0066	Microstructure Inspection Method For Deformed Aluminum and Aluminum Alloy Products Part 1 Microstructure Inspection Method Determination of Grain Size and Planar Grain Dislocation Method (7.3)	DE/T 3240.1-2012
0067	Microstructure Inspection Method For Deformed Aluminum and Aluminum Alloy Products Part 1 Microstructure Inspection Method Determination of Grain Size Interpretation Method (7.4)	DE/T 3240.1-2012
0068	Steel Fracture Inspection	DE 1844-79
0069	Metallographic Microstructure of Cast Carbon Steel For General Engineering	DE 8495-87
0070	Ferrite Grain Size of Metallographic-pearlite Mixed in Cast Carbon Steel For General Engineering	DE 8495-87
0071	Evaluation of Metallographic-Nonmetallic Inclusion Level of Cast Carbon Steel For General Engineering	DE 8495-1987
0072	Modular Grading Standard of 12Cr1MoV Steel For Thermal Power Plant-Characteristics of Ferrite-Pearlite Nodular Microstructure	DL/T 775-2010
0073	Modular Grading Standard of 12Cr1MoV Steel For Thermal Power Plant-Characteristics of Ferrite-Pearlite Nodular Microstructure	DL/T 775-2010
0074	Standard For Application Inspection and Rating of Carbon Steel	DL/T 786-2001
0075	Pearlitic Spheroidization Rating Standard For No.24 Steel Used in Thermal Power Plant	DL/T 874-1999
0076	Pearlitic Spheroidization Rating Standard For No.24 Steel Used in Thermal Power Plant	DL/T 874-2001



# Operation Interface

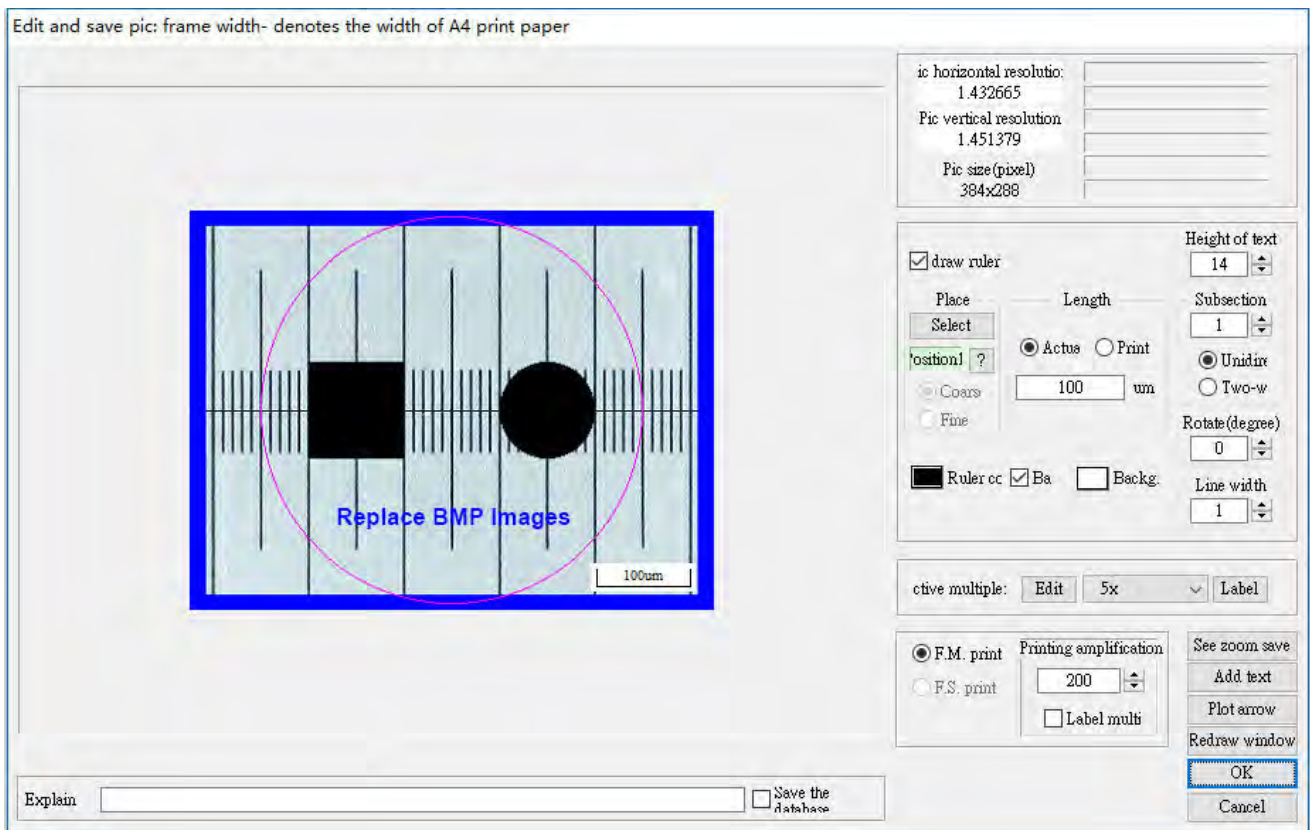
## Metallographic Grade Evaluation Function



- Comprehensive testing coverage: It covers mainstream testing items such as grain size, non-metallic inclusions, ductile iron and ferrite in stainless steel welds, and is adapted to national and international standard modules to meet the metallographic testing needs of various products.
- Adaptation of dual grading modes: It supports manual comparison grading and automatic quantitative grading. The former enables intuitive atlas comparison, while the latter accurately identifies microstructures and automatically calculates parameters, taking into account different testing scenarios and precision requirements.
- Convenient module retrieval: Testing modules can be sorted by number/standard number or quickly retrieved by keywords, which greatly improves the efficiency of module searching and makes the operation more efficient.
- Manual correction of results: It supports manual adjustment of metallographic microstructure attributes, addition/deletion of feature points and correction of automatic identification deviations. It also supports multi-field statistics for averaging to ensure the accuracy of grading results.
- Seamless connection of results to reports: Grading results can be directly linked to the report generation function, and standardized reports in PDF/WORD/EXCEL formats can be exported with one click, realizing a closed loop of the entire process from testing and grading to report generation.

# Operation Interface

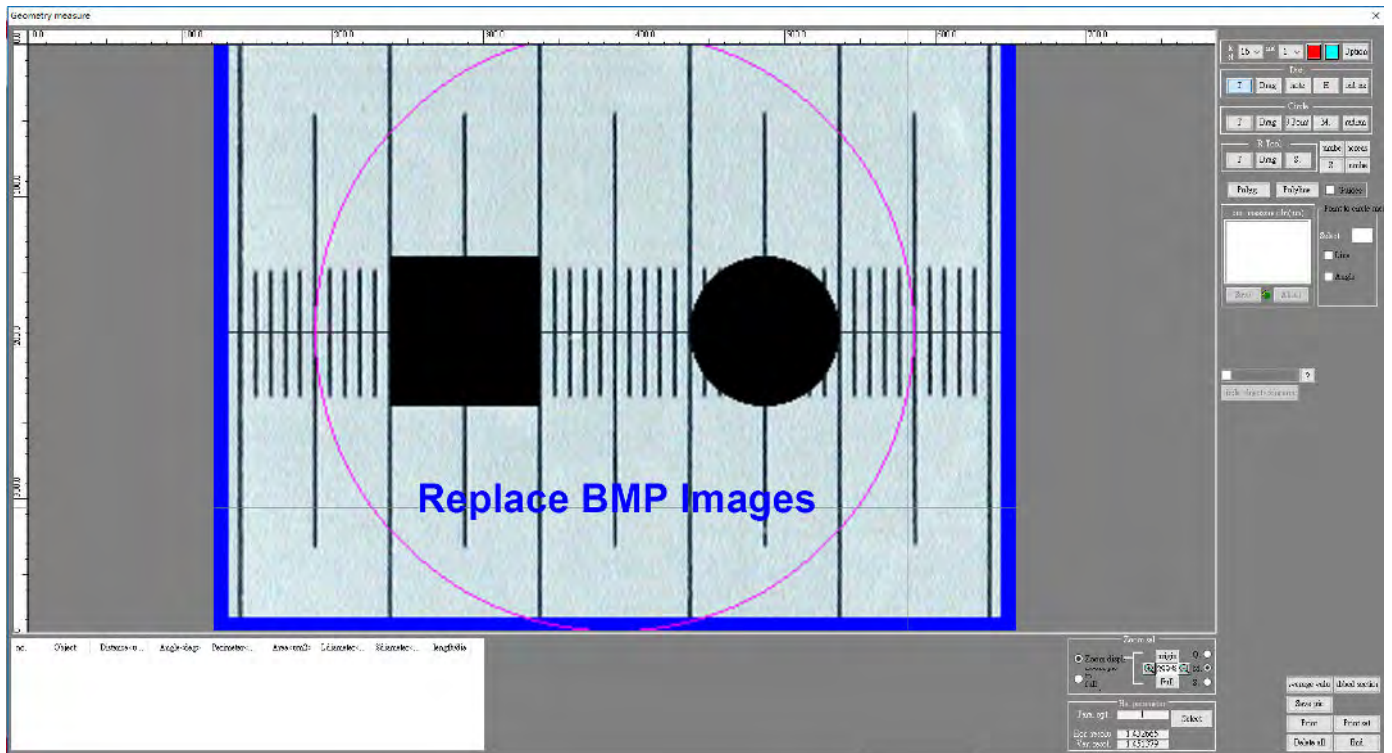
## Image Preprocessing



- Rich processing tools: It is equipped with dozens of professional tools such as brightness/-contrast adjustment, binarization, sharpening and softening, filtering and denoising and morphological operations to meet the optimization needs of various metallographic images.
- Flexible selection operation: It supports multiple selection methods including rectangle, ellipse and polygon. Selections can be moved and rotated, and precise pixel-based selection is also available, adapting to local and overall image processing scenarios.
- Customized output: Scales, text and arrows can be added when saving images, the printing magnification can be customized, and fixed-scale printing settings are supported to meet the requirements of standardized output.
- Efficient and convenient operation: Commonly used processing functions are integrated into exclusive panels, which can be called with one click without searching through multiple layers of menus, greatly improving the efficiency of image preprocessing.
- Complete data retention: It supports saving selected areas/entire images in BMP/JPG formats, the processing process is traceable, and the processed images can be directly connected to grading, measurement and report functions for smooth process connection.

# Operation Interface

## Geometric Measurement



- Complete measurement tools: It supports various types of measurement including distance, rectangle, circle, polygon, angle, radian and point-to-center distance, covering the full-dimensional geometric measurement needs of metallographic testing.
- Units such as nm/um/mm can be freely selected, and the directions of measuring lines, arrows and text can be customized.
- Measurement results can generate image-text reports in real time and can also be directly imported into Excel for secondary analysis.

# Operation Interface

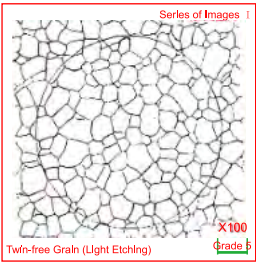
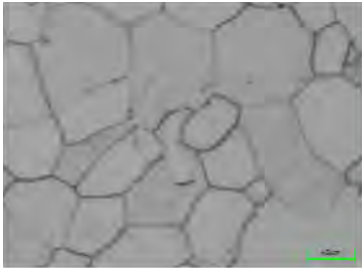
## Report Export

(Report name)

(Submission unit) Sample Submission Date: 2018-01-01

(Submission unit)	(Submission unit)
(Sample Variables)	(Sample Variables)
(Test number)	(Test number)
Inspection Item & Assessed Grade:	Item: Average Grain Size of Metals - Test Method for Average Grain Size of Metals (Area Method) (GB/T 6394-2017(8.2) & JIS G 0551:2005) Grade Type: Series of Images   Twin-free Grain (Light Etching); Grade 5 <Comparison Method>

Image for Sample No.1; (Print Magnification: 280×) Image for Sample No.2; (Print Magnification: 171×)



(Remarks)	(Remarks)
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(Surveyor) (Check) Sample Submission Date: 2018-01-01

- It supports universal report formats for single/multiple images, which can be selected on demand to adapt to the report presentation needs of different testing scenarios. Grading and measurement results can be exported in three mainstream formats (PDF/WORD/EXCEL) with one click, meeting different usage needs such as filing, editing and data statistics.
- Grading and measurement results can be directly linked to report generation without manual data entry, realizing the seamless connection of testing, results and reports and improving the efficiency of report generation.